TPS54478 2.95-V to 6-V Input, 4-A Synchronous Step-Down SWIFT™ Converter
With Hiccup Current Limit

1 Features
1. Two 30-mΩ (typical) MOSFETs for High Efficiency at 4-A Loads
2. 200-kHz to 2-MHz Switching Frequency
3. 0.6-V ± 1% Voltage Reference Over Temperature (–40°C to +150°C)
4. Start-up With Prebiased Voltage
5. Synchronizes to External Clock
6. Adjustable Slow Start / Sequencing
7. UV and OV Power-Good Output
9. Thermally Enhanced 3-mm × 3-mm 16-Pin WQFN (RTE)
10. Pin Compatible to TPS54418
11. Create a Custom Design Using the TPS54478 With the WEBENCH® Power Designer

2 Applications
1. Low-Voltage, High-Density Power Systems
2. Point-of-Load Regulation for High Performance DSPs, FPGAs, ASICs, and Microprocessors
3. Broadband, Networking, and Optical Communications Infrastructure

3 Description
The TPS54478 device is a full featured 6-V, 4-A, synchronous step down current mode converter with two integrated MOSFETs.

The TPS54478 enables small designs by integrating the MOSFETs, implementing current mode control to reduce external component count, reducing inductor size by enabling up to 2-MHz switching frequency, and minimizing the IC footprint with a small 3-mm × 3-mm thermally enhanced WQFN package.

The TPS54478 provides accurate regulation for a variety of loads with an accurate ±1% voltage reference ($V_{REF}$) over temperature. Efficiency is maximized through the integrated 30-mΩ MOSFETs and 525-μA typical supply current. Using the enable pin, shutdown supply current is reduced to 2.5 μA by entering a shutdown mode.

Undervoltage lockout is internally set at 2.6 V, but can be increased by programming the threshold with a resistor network on the enable pin. The output voltage start-up ramp is controlled by the soft-start pin. An open-drain power-good signal indicates the output is within 93% to 107% of its nominal voltage.

Cycle-by-cycle current limit, hiccup overcurrent protection, and thermal shutdown protect the device during an overcurrent condition.

For more SWIFT™ documentation, see the TI website at www.ti.com/swift.

Device Information

<table>
<thead>
<tr>
<th>PART NUMBER</th>
<th>PACKAGE</th>
<th>BODY SIZE (NOM)</th>
</tr>
</thead>
<tbody>
<tr>
<td>TPS54478</td>
<td>WQFN (16)</td>
<td>3.00 mm × 3.00 mm</td>
</tr>
</tbody>
</table>

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Efficiency

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.
Table of Contents

1 Features ......................................................... 1
2 Applications .................................................. 1
3 Description .................................................... 1
4 Revision History ............................................... 2
5 Pin Configuration and Functions ......................... 3
6 Specifications .................................................. 4
    6.1 Absolute Maximum Ratings ......................... 4
    6.2 ESD Ratings .............................................. 4
    6.3 Recommended Operating Conditions ............... 4
    6.4 Thermal Information .................................. 5
    6.5 Electrical Characteristics .......................... 5
    6.6 Typical Characteristics .............................. 7
7 Detailed Description ......................................... 11
    7.1 Overview .................................................. 11
    7.2 Functional Block Diagram ............................ 12
    7.3 Feature Description ................................... 12
    7.4 Device Functional Modes ............................ 21
    7.5 Programming ............................................. 21
8 Application and Implementation .......................... 22
    8.1 Application Information .............................. 22
    8.2 Typical Application .................................... 22
9 Power Supply Recommendations ........................... 30
10 Layout ......................................................... 31
    10.1 Layout Guidelines .................................... 31
    10.2 Layout Example ....................................... 31
    10.3 Power Dissipation Estimate ......................... 32
11 Device and Documentation Support ...................... 33
    11.1 Device Support .......................................... 33
    11.2 Documentation Support .............................. 33
    11.3 Receiving Notification of Documentation Updates 33
    11.4 Community Resources ............................... 33
    11.5 Trademarks ............................................. 33
    11.6 Electrostatic Discharge Caution ................... 34
    11.7 Glossary ............................................... 34
12 Mechanical, Packaging, and Orderable Information .... 34

4 Revision History

Changes from Revision A (November 2016) to Revision B Page

• Update title to include key features; add links for WEBENCH; delete link to SwitcherPro tool ................................. 1

Changes from Original (June 2011) to Revision A Page

• Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section .................................................. 1
• Deleted Ordering Information table; see POA at the end of the datasheet. ................................................................. 1
## 5 Pin Configuration and Functions

### RTE Package
16-Pin WQFN
Top View

<table>
<thead>
<tr>
<th>PIN</th>
<th>I/O</th>
<th>DESCRIPTION</th>
</tr>
</thead>
<tbody>
<tr>
<td>AGND</td>
<td>5</td>
<td>—</td>
</tr>
<tr>
<td>BOOT</td>
<td>13</td>
<td>O</td>
</tr>
<tr>
<td>COMP</td>
<td>7</td>
<td>I/O</td>
</tr>
<tr>
<td>EN</td>
<td>15</td>
<td>I</td>
</tr>
<tr>
<td>GND</td>
<td>3, 4</td>
<td>—</td>
</tr>
<tr>
<td>PH</td>
<td>10, 11, 12</td>
<td>O</td>
</tr>
<tr>
<td>PWRGD</td>
<td>14</td>
<td>O</td>
</tr>
<tr>
<td>RT/CLK</td>
<td>8</td>
<td>I</td>
</tr>
<tr>
<td>SS/TR</td>
<td>9</td>
<td>I</td>
</tr>
<tr>
<td>Thermal Pad</td>
<td>17</td>
<td>—</td>
</tr>
<tr>
<td>VIN</td>
<td>1, 2, 16</td>
<td>I</td>
</tr>
<tr>
<td>VSENSE</td>
<td>6</td>
<td>I</td>
</tr>
</tbody>
</table>
### 6 Specifications

#### 6.1 Absolute Maximum Ratings\(^{(1)}\)

<table>
<thead>
<tr>
<th></th>
<th>MIN</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>Input voltage</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>VIN</td>
<td>–0.3</td>
<td>7</td>
<td>V</td>
</tr>
<tr>
<td>EN</td>
<td>–0.3</td>
<td>7</td>
<td>V</td>
</tr>
<tr>
<td>BOOT</td>
<td>PH + 7</td>
<td></td>
<td></td>
</tr>
<tr>
<td>VSENSE</td>
<td>–0.3</td>
<td>3</td>
<td>V</td>
</tr>
<tr>
<td>COMP</td>
<td>–0.3</td>
<td>3</td>
<td>V</td>
</tr>
<tr>
<td>PWRGD</td>
<td>–0.3</td>
<td>7</td>
<td>V</td>
</tr>
<tr>
<td>SS/TR</td>
<td>–0.3</td>
<td>3</td>
<td>V</td>
</tr>
<tr>
<td>RT/CLK</td>
<td>–0.3</td>
<td>3.3</td>
<td>V</td>
</tr>
<tr>
<td>Output voltage</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>BOOT-PH</td>
<td>–0.6</td>
<td>7</td>
<td>V</td>
</tr>
<tr>
<td>PH</td>
<td></td>
<td>10</td>
<td>V</td>
</tr>
<tr>
<td>PH 10 ns Transient</td>
<td>–2</td>
<td>10</td>
<td></td>
</tr>
<tr>
<td>Source current</td>
<td></td>
<td></td>
<td>µA</td>
</tr>
<tr>
<td>EN</td>
<td>100</td>
<td></td>
<td></td>
</tr>
<tr>
<td>RT/CLK</td>
<td>100</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Sink current</td>
<td></td>
<td></td>
<td>µA</td>
</tr>
<tr>
<td>COMP</td>
<td>100</td>
<td></td>
<td></td>
</tr>
<tr>
<td>PWRGD</td>
<td>10</td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td>SS/TR</td>
<td>100</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Junction Temperature, T(_j)</td>
<td>–40</td>
<td>150</td>
<td>°C</td>
</tr>
<tr>
<td>Storage Temperature, T(_{stg})</td>
<td>–65</td>
<td>150</td>
<td>°C</td>
</tr>
</tbody>
</table>

\(^{(1)}\) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Electrical Characteristics is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 6.2 ESD Ratings

<table>
<thead>
<tr>
<th></th>
<th>VALUE</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>V(_{(ESD)}) Electrostatic discharge</td>
<td>Human-body model (HBM), per QSS 009-105 (JESD22-A114A)(^{(1)})</td>
<td>±2000</td>
</tr>
<tr>
<td></td>
<td>Charged-device model (CDM), per JEDEC specification JESD22-C101(^{(2)})</td>
<td>±500</td>
</tr>
</tbody>
</table>

\(^{(1)}\) The human body model is a 100-pF capacitor discharged through a 1.5-kΩ resistor into each pin. The machine model is a 200-pF capacitor discharged directly into each pin.

\(^{(2)}\) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

#### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

<table>
<thead>
<tr>
<th></th>
<th>MIN</th>
<th>NOM</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>Input Voltage Range</td>
<td>2.95</td>
<td></td>
<td>6</td>
<td>V</td>
</tr>
<tr>
<td>Output Current</td>
<td>0</td>
<td></td>
<td>4</td>
<td>A</td>
</tr>
<tr>
<td>Operating Junction Temperature Range, T(_j)</td>
<td>–40</td>
<td>150</td>
<td>°C</td>
<td></td>
</tr>
</tbody>
</table>
6.4 Thermal Information

<table>
<thead>
<tr>
<th>THERMAL METRIC(1)(2)(3)</th>
<th>TPS54478 RTE (WQFN)</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>( R_{\theta JA} ) Junction-to-ambient thermal resistance</td>
<td>49.1</td>
<td>°C/W</td>
</tr>
<tr>
<td>( R_{\theta JC(top)} ) Junction-to-case (top) thermal resistance</td>
<td>0.7</td>
<td>°C/W</td>
</tr>
<tr>
<td>( R_{\theta JB} ) Junction-to-board thermal resistance</td>
<td>21.8</td>
<td>°C/W</td>
</tr>
<tr>
<td>( \psi_{JT} ) Junction-to-top characterization parameter</td>
<td>50.7</td>
<td>°C/W</td>
</tr>
<tr>
<td>( \psi_{JB} ) Junction-to-board characterization parameter</td>
<td>7.5</td>
<td>°C/W</td>
</tr>
<tr>
<td>( R_{\theta JC(bot)} ) Junction-to-case (bottom) thermal resistance</td>
<td>21.8</td>
<td>°C/W</td>
</tr>
</tbody>
</table>

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.
(2) Maximum power dissipation may be limited by overcurrent protection.
(3) Power rating at a specific ambient temperature \( T_A \) should be determined with a junction temperature of 150°C. This is the point where distortion starts to substantially increase. Thermal management of the PCB should strive to keep the junction temperature at or below 150°C for best performance and long-term reliability. See power dissipation estimate in application section of this data sheet for more information.

6.5 Electrical Characteristics

\( T_J = -40^\circ C \) to 150°C, \( VIN = 2.95 \) to 6 V (unless otherwise noted)

<table>
<thead>
<tr>
<th>DESCRIPTION</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>SUPPLY VOLTAGE (VIN PIN)</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Operating input voltage</td>
<td></td>
<td>2.95</td>
<td>6.0</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Input under voltage lockout threshold</td>
<td>No voltage hysteresis</td>
<td></td>
<td>2.6</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Shutdown supply current</td>
<td>( EN = 0 ) V, 25°C, 2.95 V ≤ VIN ≤ 6 V</td>
<td></td>
<td>0.7</td>
<td>2.5</td>
<td>μA</td>
</tr>
<tr>
<td>Quiescent Current - ( I_q )</td>
<td>( VSENSE = 0.7 ) V, ( VIN = 5 ) V, 25°C, ( RT = 78.7 ) kΩ</td>
<td></td>
<td>525</td>
<td>700</td>
<td>μA</td>
</tr>
<tr>
<td>ENABLE AND UVLO (EN PIN)</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Enable threshold</td>
<td>Rising</td>
<td></td>
<td>1.30</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td></td>
<td>Falling</td>
<td></td>
<td>1.21</td>
<td></td>
<td></td>
</tr>
<tr>
<td>Input current</td>
<td>Enable threshold + 50 mV</td>
<td></td>
<td>–3.4</td>
<td>μA</td>
<td></td>
</tr>
<tr>
<td></td>
<td>Enable threshold – 50 mV</td>
<td></td>
<td>–0.64</td>
<td></td>
<td></td>
</tr>
<tr>
<td>VOLTAGE REFERENCE (VSENSE PIN)</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Voltage Reference</td>
<td>2.95 V ≤ VIN ≤ 6 V, ( -40^\circ C &lt; T_J &lt; 150^\circ C )</td>
<td></td>
<td>0.594</td>
<td>0.600</td>
<td>0.606</td>
</tr>
<tr>
<td>MOSFET</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>High side switch resistance</td>
<td>( \text{BOOT-PH} = 5 ) V</td>
<td></td>
<td>30</td>
<td>60</td>
<td>mΩ</td>
</tr>
<tr>
<td></td>
<td>( \text{BOOT-PH} = 3.3 ) V</td>
<td></td>
<td>37</td>
<td>70</td>
<td>mΩ</td>
</tr>
<tr>
<td>Low side switch resistance</td>
<td>( VIN = 5 ) V</td>
<td></td>
<td>30</td>
<td>60</td>
<td>mΩ</td>
</tr>
<tr>
<td></td>
<td>( VIN = 3.3 ) V</td>
<td></td>
<td>37</td>
<td>70</td>
<td></td>
</tr>
<tr>
<td>ERROR AMPLIFIER</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Input current</td>
<td></td>
<td></td>
<td>7</td>
<td>nA</td>
<td></td>
</tr>
<tr>
<td>Error amplifier transconductance (gm)</td>
<td>( -2 ) μA &lt; ( I_{\text{COMP}} ) &lt; 2 μA, ( V_{\text{COMP}} = 1 ) V</td>
<td></td>
<td>225</td>
<td></td>
<td>μmhos</td>
</tr>
<tr>
<td>Error amplifier transconductance (gm) during slow start</td>
<td>( -2 ) μA &lt; ( I_{\text{COMP}} ) &lt; 2 μA, ( V_{\text{COMP}} = 1 ) V, ( V_{\text{Ssense}} = 0.4 ) V</td>
<td></td>
<td>77</td>
<td></td>
<td>μmhos</td>
</tr>
<tr>
<td>Error amplifier source/sink</td>
<td>( V_{\text{COMP}} = 1 ) V, 100 mV overdrive</td>
<td></td>
<td>±20</td>
<td>μA</td>
<td></td>
</tr>
<tr>
<td>COMP to Iswitch gm</td>
<td></td>
<td></td>
<td>14</td>
<td>A/V</td>
<td></td>
</tr>
<tr>
<td>CURRENT LIMIT</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Current limit threshold</td>
<td>( VIN = 6V, F_s = 500 ) KHz</td>
<td></td>
<td>5.2</td>
<td>6.5</td>
<td>8.2</td>
</tr>
<tr>
<td>Cycles before entering hiccup</td>
<td></td>
<td></td>
<td>512</td>
<td></td>
<td>Cycles</td>
</tr>
<tr>
<td>Cycles of converter in off state during hiccup</td>
<td></td>
<td></td>
<td>16384</td>
<td></td>
<td>Cycles</td>
</tr>
<tr>
<td>Low side Fet reverse current limit</td>
<td></td>
<td></td>
<td>3.1</td>
<td></td>
<td>A</td>
</tr>
<tr>
<td>THERMAL SHUTDOWN</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Thermal shutdown</td>
<td></td>
<td></td>
<td>165</td>
<td></td>
<td>°C</td>
</tr>
</tbody>
</table>
### Electrical Characteristics (continued)

**T<sub>j</sub> = −40°C to 150°C, VIN = 2.95 to 6 V (unless otherwise noted)**

<table>
<thead>
<tr>
<th>DESCRIPTION</th>
<th>TEST CONDITIONS</th>
<th>MIN</th>
<th>TYP</th>
<th>MAX</th>
<th>UNIT</th>
</tr>
</thead>
<tbody>
<tr>
<td>Hysteresis</td>
<td></td>
<td>15</td>
<td></td>
<td></td>
<td>°C</td>
</tr>
<tr>
<td><strong>TIMING RESISTOR AND EXTERNAL CLOCK (RT/CLK PIN)</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Switching frequency range using RT mode</td>
<td></td>
<td>200</td>
<td>2000</td>
<td>kHz</td>
<td></td>
</tr>
<tr>
<td>Switching frequency</td>
<td>$R_{(RT/CLK)} = 78.7 , \text{kΩ}$</td>
<td>400</td>
<td>500</td>
<td>600</td>
<td>kHz</td>
</tr>
<tr>
<td>Switching frequency range using CLK mode</td>
<td></td>
<td>300</td>
<td>2000</td>
<td>kHz</td>
<td></td>
</tr>
<tr>
<td>Minimum CLK pulse width</td>
<td></td>
<td>75</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>RT/CLK voltage</td>
<td>$R_{(RT/CLK)} = 78.7 , \text{kΩ}$</td>
<td></td>
<td>0.5</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>RT/CLK high threshold</td>
<td></td>
<td>1.6</td>
<td>2.2</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>RT/CLK low threshold</td>
<td></td>
<td>0.4</td>
<td>0.6</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>RT/CLK falling edge to PH rising edge delay</td>
<td>Measure at 500 kHz with RT resistor in series</td>
<td>75</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>PLL lock in time</td>
<td>Measure at 500 kHz</td>
<td>14</td>
<td></td>
<td></td>
<td>µs</td>
</tr>
<tr>
<td><strong>PH (PH PIN)</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Minimum On time</td>
<td>Measured at 50% points on PH, VIN = 5 V, $I_{OUT} = 2$ A</td>
<td>100</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>Minimum Off time</td>
<td>Measured at 50% points on PH, VIN = 5 V, $I_{OUT} = 0$ A</td>
<td>120</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>Rise Time</td>
<td>Prior to skipping off pulses, VIN = 5 V, $I_{OUT} = 2$ A</td>
<td>110</td>
<td></td>
<td></td>
<td>ns</td>
</tr>
<tr>
<td>Fall Time</td>
<td>VIN = 5 V, 4 A</td>
<td>1.5</td>
<td></td>
<td></td>
<td>V/ns</td>
</tr>
<tr>
<td><strong>BOOT (BOOT PIN)</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>BOOT Charge Resistance</td>
<td>VIN = 5 V</td>
<td>15</td>
<td></td>
<td></td>
<td>Ω</td>
</tr>
<tr>
<td><strong>SLOW START AND TRACKING (SS/TR PIN)</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>SS voltage threshold ($V_{SS_THR}$)</td>
<td></td>
<td>0.15</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>Charge Current</td>
<td>$V_{(SS_TR)} &lt; V_{SS_THR}$</td>
<td>45</td>
<td></td>
<td></td>
<td>µA</td>
</tr>
<tr>
<td></td>
<td>$V_{(SS_TR)} &gt; V_{SS_THR}$</td>
<td>2.2</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>SS/TR to VSENSE matching</td>
<td>$V_{(SS_TR)} = 0.3$ V</td>
<td>65</td>
<td></td>
<td></td>
<td>mV</td>
</tr>
<tr>
<td>SS/TR to reference crossover</td>
<td>98% normal</td>
<td>0.86</td>
<td></td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>SS/TR discharge voltage (Overload)</td>
<td>VSENSE = 0 V</td>
<td>2.5</td>
<td></td>
<td></td>
<td>mV</td>
</tr>
<tr>
<td>SS/TR discharge current (Overload)</td>
<td>VSENSE = 0 V, $V_{(SS_TR)} = 0.4$ V</td>
<td>900</td>
<td></td>
<td></td>
<td>µA</td>
</tr>
<tr>
<td>SS discharge current (UVLO, EN, Thermal fault)</td>
<td>VIN = 5 V, $V_{(SS)} = 0.5$ V</td>
<td>1.16</td>
<td></td>
<td></td>
<td>mA</td>
</tr>
<tr>
<td><strong>POWER GOOD (PWRGD PIN)</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>VSENSE threshold</td>
<td>VSENSE falling (Fault)</td>
<td>93</td>
<td></td>
<td></td>
<td>% Vref</td>
</tr>
<tr>
<td></td>
<td>VSENSE rising (Good)</td>
<td>95</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>VSENSE rising (Fault)</td>
<td>107</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>VSENSE falling (Good)</td>
<td>105</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Hysteresis</td>
<td>VSENSE falling</td>
<td>2</td>
<td></td>
<td></td>
<td>% Vref</td>
</tr>
<tr>
<td>Output high leakage</td>
<td>VSENSE = VREF, $V_{(PWRGD)} = 5.5$ V</td>
<td>7</td>
<td></td>
<td></td>
<td>nA</td>
</tr>
<tr>
<td>On resistance</td>
<td>VIN = 2.95 V</td>
<td>56</td>
<td>120</td>
<td></td>
<td>Ω</td>
</tr>
<tr>
<td>Output low</td>
<td>$I_{(PWRGD)} = 3$ mA</td>
<td>0.2</td>
<td>0.3</td>
<td></td>
<td>V</td>
</tr>
<tr>
<td>Minimum VIN for valid output</td>
<td>$V_{(PWRGD)} &lt; 0.5$ V at 100 µA</td>
<td>1.2</td>
<td>1.6</td>
<td></td>
<td>V</td>
</tr>
</tbody>
</table>
6.6 Typical Characteristics

Figure 1. Shutdown Supply Current vs Temperature

Figure 2. VIN Supply Current vs Temperature

Figure 3. EN Pin Voltage vs Temperature

Figure 4. EN Pin Current vs Temperature

Figure 5. Voltage Reference vs Temperature

Figure 6. MOSFET Rdson vs Temperature
Typical Characteristics (continued)

![Figure 7. Transconductance vs Temperature](image)

![Figure 8. High Side FET Current Limit vs Temperature](image)

![Figure 9. Switching Frequency vs RT Resistance](image)

![Figure 10. Switching Frequency vs Temperature](image)

![Figure 11. VSS Voltage Threshold VSSTHR vs Temperature](image)

![Figure 12. SS Charge Current vs Temperature](image)
Typical Characteristics (continued)

-\[ V = 2.5 \text{ V} \]
-\[ V_{\text{in}} = 3.3 \text{ V}, \quad \text{DCR} = 6.8 \text{ m} \text{Ω} \]
-\[ f_s = 1 \text{ MHz} \]
-\[ T_j = 25^{\circ} \text{C} \]

\[ \text{Figure 13. SS Charge Current vs Temperature} \]

\[ \text{Figure 14. PWRGD Rdson vs Temperature} \]

\[ \text{Figure 15. PWRGD Threshold vs Temperature} \]

\[ \text{Figure 16. PWRGD Leakage Current vs Temperature} \]

\[ \text{Figure 17. Efficiency vs Load Current} \]

\[ \text{Figure 18. Efficiency vs Load Current} \]
Typical Characteristics (continued)

Figure 19. Efficiency vs Load Current

Figure 20. Efficiency vs Load Current
7 Detailed Description

7.1 Overview

The TPS54478 is a 6-V, 4-A, synchronous step-down (buck) converter with two integrated n-channel MOSFETs. To improve performance during line and load transients the device implements a constant frequency, peak current mode control which reduces output capacitance and simplifies external frequency compensation design. The wide switching frequency of 200 kHz to 2000 kHz allows for efficiency and size optimization when selecting the output filter components. The switching frequency is adjusted using a resistor to ground on the RT/CLK pin. The device has an internal phase lock loop (PLL) on the RT/CLK pin that is used to synchronize the power switch turn on to a falling edge of an external system clock.

The TPS54478 has a typical default start up voltage of 2.6 V. The EN pin has an internal pull-up current source that can be used to adjust the input voltage under voltage lockout (UVLO) with two external resistors. In addition, the pull up current provides a default condition when the EN pin is floating for the device to operate. The total operating current for the TPS54478 is typically 525 μA when not switching and under no load. When the device is disabled, the supply current is less than 2.5 μA.

The integrated 30 mΩ MOSFETs allow for high efficiency power supply designs with continuous output currents up to 4 amperes.

The TPS54478 reduces the external component count by integrating the boot recharge diode. The bias voltage for the integrated high side MOSFET is supplied by a capacitor between the BOOT and PH pins. The boot capacitor voltage is monitored by an UVLO circuit and turns off the high side MOSFET when the voltage falls below a preset threshold. This BOOT circuit allows the TPS54478 to operate approaching 100%. The output voltage can be stepped down to as low as the 0.600 V reference.

TPS54478 features monotonic startup under pre-bias conditions. The low side Fet turns on for a very short time period every cycle before the output voltage reaches the pre-biased voltage. This ensures the boot cap has enough charge to turn on the top Fet when the output voltage reaches the pre-biased voltage.

The TPS54478 has a power good comparator (PWRGD) with 2% hysteresis.

The TPS54478 minimizes excessive output overvoltage transients by taking advantage of the overvoltage power good comparator. When the regulated output voltage is greater than 107% of the nominal voltage, the overvoltage comparator is activated, and the high side MOSFET is turned off and masked from turning on until the output voltage is lower than 105%.

The SS/TR (slow start/tracking) pin is used to minimize inrush currents or provide power supply sequencing during power up. A small value capacitor should be coupled to the pin for slow start. The SS/TR pin is discharged before the output power up to ensure a repeatable restart after an overtemperature fault, UVLO fault or disabled condition. To optimize the output startup waveform, two levels of SS current are implemented. The first slope has more current so that the converter can get out of the region requiring small minimum ON time.

To reduce the power dissipation of TPS54478 during overcurrent event, the hiccup protection is implemented beyond the cycle-by-cycle protection. Thermal shutdown prevents the overheat damage of the device.
7.2 Functional Block Diagram

7.3 Feature Description

7.3.1 Fixed Frequency PWM Control

The TPS54478 uses an adjustable fixed frequency, peak current mode control. The output voltage is compared through external resistors on the VSENSE pin to an internal voltage reference by an error amplifier which drives the COMP pin. An internal oscillator initiates the turn on of the high side power switch. The error amplifier output is compared to the high side power switch current. When the power switch current reaches the COMP voltage level the high side power switch is turned off and the low side power switch is turned on. The COMP pin voltage increases and decreases as the output current increases and decreases. The device implements a current limit by clamping the COMP pin voltage to a maximum level and also implements a minimum clamp for improved transient response performance.

7.3.2 Slope Compensation and Output Current

The TPS54478 adds a compensating ramp to the switch current signal. This slope compensation prevents sub-harmonic oscillations as duty cycle increases. The available peak inductor current remains constant over the full duty cycle range.
Feature Description (continued)

7.3.3 Bootstrap Voltage (BOOT) and Low Dropout Operation

The TPS54478 has an integrated boot regulator and requires a small ceramic capacitor between the BOOT and PH pin to provide the gate drive voltage for the high side MOSFET. The value of the ceramic capacitor should be 0.1 μF. A ceramic capacitor with an X7R or X5R grade dielectric with a voltage rating of 10 V or higher is recommended because of the stable characteristics over temperature and voltage.

To improve drop out, the TPS54478 is designed to operate at 100% duty cycle as long as the BOOT to PH pin voltage is greater than 2.2 V. The high side MOSFET is turned off using an UVLO circuit, allowing for the low side MOSFET to conduct when the voltage from BOOT to PH drops below 2.2 V. Since the supply current sourced from the BOOT pin is very low, the high side MOSFET can remain on for more switching cycles than are required to refresh the capacitor, thus the effective duty cycle of the switching regulator is very high.

7.3.4 Error Amplifier

The TPS54478 has a transconductance amplifier. The error amplifier compares the VSENSE voltage to the lower of the SS/TR pin voltage or the internal 0.600 V voltage reference. The transconductance of the error amplifier is 225 μA/V during normal operation. When the voltage of VSENSE pin is below 0.600 V and the device is regulating using the SS/TR voltage, the gm is typically greater than 77 μA/V, but less than 225 μA/V. The frequency compensation components are placed between the COMP pin and ground.

7.3.5 Voltage Reference

The voltage reference system produces a precise ±1% voltage reference over temperature by scaling the output of a temperature-stable bandgap circuit. The bandgap and scaling circuits produce 0.600 V at the non-inverting input of the error amplifier.

7.3.6 Adjusting the Output Voltage

The output voltage is set with a resistor divider from the output node to the VSENSE pin. It is recommended to use divider resistors with 1% tolerance or better. Start with a 20 kΩ for the R1 resistor and use the Equation 1 to calculate R2. To improve efficiency at very light loads consider using larger value resistors. If the values are too high the regulator is more susceptible to noise and voltage errors from the VSENSE input current are noticeable.

\[ R2 = R1 \times \left( \frac{0.6 \text{ V}}{V_O - 0.6 \text{ V}} \right) \]  

(1)

![Voltage Divider Circuit](Figure 21)
### Feature Description (continued)

#### 7.3.7 Enable and Adjusting Undervoltage Lockout

The TPS54478 is disabled when the VIN pin voltage falls below 2.6 V. If an application requires a higher undervoltage lockout (UVLO), use the EN pin as shown in Figure 22 to adjust the input voltage UVLO by using two external resistors. It is recommended to use the EN resistors to set the UVLO falling threshold (V\(_{STOP}\)) above 2.6 V. The rising threshold (V\(_{START}\)) should be set to provide enough hysteresis to allow for any input supply variations. The EN pin has an internal pull-up current source that provides the default condition of the TPS54478 operating when the EN pin floats. Once the EN pin voltage exceeds 1.30 V, an additional 2.76 μA of hysteresis is added. When the EN pin is pulled below 1.21 V, the 2.76 μA is removed. This additional current facilitates input voltage hysteresis.

![Figure 22. Adjustable Undervoltage Lockout](image)

\[
R_1 = \frac{V_{START} \left( \frac{V_{ENFALLING}}{V_{ENRISING}} \right) - V_{STOP}}{I_p \left( 1 - \frac{V_{ENFALLING}}{V_{ENRISING}} \right) + I_h}
\]

\[
R_2 = \frac{R_1 \times V_{ENFALLING}}{V_{STOP} - V_{ENFALLING} + R_1(l_p + h)}
\]

Where \(I_h = 2.76 \, \mu A, \, I_p = 0.64 \, \mu A, \, V_{ENRISING} = 1.30 \, V, \, V_{ENFALLING} = 1.21 \, V\)

#### 7.3.8 Slow Start / Tracking Pin

The TPS54478 regulates to the lower of the SS/TR pin and the internal reference voltage. A capacitor on the SS/TR pin to ground implements a slow start time. Before the SS pin reaches the voltage threshold \(V_{SSTHR}\), the charge current is about 45 μA. The TPS54478 internal pull-up current source of 2.2 μA charges the external slow start capacitor after the SS pin voltage exceeds \(V_{SSTHR}\). Equation 4 calculates the required slow start capacitor value where \(T_{ss}\) is the desired slow start time in ms and \(C_{ss}\) is the required capacitance in nF.

\[
C_{ss}(nF) = 3 \times T_{ss}(mS)
\]

If during normal operation, the VIN goes below the UVLO, EN pin pulled below 1.21 V, or a thermal shutdown event occurs, the TPS54478 stops switching. When the VIN goes above UVLO, EN is released or pulled high, or a thermal shutdown is exited, then SS/TR is discharged to below 65 mV before reinitiating a powering up sequence. The VSENSE voltage will follow the SS/TR pin voltage with a 65mV offset up to 90% of the internal voltage reference. When the SS/TR voltage is greater than 90% of the internal reference voltage the offset increases as the effective system reference transitions from the SS/TR voltage to the internal voltage reference.
Simultaneous power supply sequencing can be implemented by connecting the resistor network of R1 and R2 shown in Figure 27 to the output of the power supply that needs to be tracked or another voltage reference source. Using Equation 5 and Equation 6, the tracking resistors can be calculated. To minimize the effect of the inherent SS/TR to VSENSE offset (Vssoffset) in the slow start circuit and the offset created by the pullup current source (Iss) and tracking resistors, the Vssoffset and Iss are included as variables in the equations. As the SS/TR voltage becomes more than 85% of the nominal reference voltage the Vssoffset becomes larger as the slow start circuits gradually handoff the regulation reference to the internal voltage reference. The SS/TR pin voltage needs to be greater than 0.86 V for a complete handoff to the internal voltage reference as shown in Figure 28.
### Feature Description (continued)

\[
R_1 = \frac{V_{out2}}{V_{ref}} \times \frac{V_{ssoffset}}{I_{ss}}
\]

\[
R_2 = \frac{V_{ref} \times R_1}{V_{out2} - V_{ref}}
\]

(5)

(6)

---

#### 7.3.9 Constant Switching Frequency and Timing Resistor (RT/CLK Pin)

The switching frequency of the TPS54478 is adjustable over a wide range from 200 kHz to 2000 kHz by placing a maximum of 150 kΩ and minimum of 16 kΩ, respectively, on the RT/CLK pin. An internal amplifier holds this pin at a fixed voltage when using an external resistor to ground to set the switching frequency. The RT/CLK is typically 0.5 V. To determine the timing resistance for a given switching frequency, use the curve in Figure 5 or Equation 7.

\[
RT (k\Omega) = \frac{90066}{F_s(kHz)^{1.135}}
\]

(7)

\[
F_s(kHz) = \frac{23439}{RT(k\Omega)^{0.8813}}
\]

(8)

To reduce the solution size one would typically set the switching frequency as high as possible, but tradeoffs of the efficiency, maximum input voltage and minimum controllable on time should be considered.

The minimum controllable on time is typically 100 ns at full current load and 120 ns at no load, and limits the maximum operating input voltage or output voltage.
Feature Description (continued)

7.3.10 Overcurrent Protection
The TPS54478 implements current mode control which uses the COMP pin voltage to turn off the high side MOSFET and turn on the low side MOSFET on a cycle by cycle basis. Each cycle the switch current and the COMP pin voltage are compared, when the peak switch current intersects the COMP voltage the high side switch is turned off. During overcurrent conditions that pull the output voltage low, the error amplifier will respond by driving the COMP pin high, increasing the switch current. The error amplifier output is clamped internally. This clamp functions as a switch current limit. When the OCP reaches 512 cycles, the converter enters hiccup mode in which no switching action happens for about 16000 cycles. This helps the reduction of the power consumption during the over current event.

7.3.11 START-UP into Prebiased Output
The TPS54478 features monotonic startup into pre-biased output. The low side FET turns on for a very short time period every cycle before the output voltage reaches the pre-biased voltage. This ensures the boot cap has enough charge to turn on the top FET when the output voltage reaches the pre-biased voltage. The TPS54478 also implements low side current protection by detecting the voltage over the low side MOSFET. When the converter sinks current through its low side FET is more than 3.1 A, the control circuit will turn the low side FET off. Due to the implemented prebias function, the low side Fet reverse current protection should not be reached, but it provides another layer of protection in the undesired events such as oscillation induced by load.

7.3.12 Synchronize Using the RT/CLK Pin
The RT/CLK pin is used to synchronize the converter to an external system clock. See Figure 29. To implement the synchronization feature in a system, connect a square wave to the RT/CLK pin with an on time of at least 75ns. If the pin is pulled above the PLL upper threshold, a mode change occurs and the pin becomes a synchronization input. The internal amplifier is disabled and the pin is a high impedance clock input to the internal PLL. If clocking edges stop, the internal amplifier is re-enabled and the mode returns to the frequency set by the resistor. The square wave amplitude at this pin must transition lower than 0.6 V and higher than 1.6 V typically. The synchronization frequency range is 300 kHZ to 2000 kHZ. The rising edge of the PH is synchronized to the falling edge of RT/CLK pin.

![Figure 29. Synchronizing to a System Clock](image1)

Figure 29. Synchronizing to a System Clock

![Figure 30. Plot of Synchronizing to System Clock](image2)

Figure 30. Plot of Synchronizing to System Clock

7.3.13 Power Good (PWRGD Pin)
The PWRGD pin output is an open drain MOSFET. The output is pulled low when the VSENSE voltage enters the fault condition by falling below 93% or rising above 107% of the nominal internal reference voltage. There is a 2% hysteresis on the threshold voltage, so when the VSENSE voltage rises to the good condition above 95% or falls below 105% of the internal voltage reference the PWRGD output MOSFET is turned off. It is recommended to use a pull-up resistor between the values of 1 kΩ and 100 kΩ to a voltage source that is 6 V or less. The PWRGD is in a valid state once the VIN input voltage is greater than 1.6 V.
Feature Description (continued)

7.3.14 Overvoltage Transient Protection

The TPS54478 incorporates an overvoltage transient protection (OVTP) circuit to minimize voltage overshoot when recovering from output fault conditions or strong unload transients. The OVTP feature minimizes the output overshoot by implementing a circuit to compare the VSENSE pin voltage to the OVTP threshold which is 107% of the internal voltage reference. If the VSENSE pin voltage is greater than the OVTP threshold, the high side MOSFET is disabled preventing current from flowing to the output and minimizing output overshoot. When the VSENSE voltage drops lower than the OVTP threshold the high side MOSFET is allowed to turn on the next clock cycle.

7.3.15 Thermal Shutdown

The device implements an internal thermal shutdown to protect itself if the junction temperature exceeds 165°C. The thermal shutdown forces the device to stop switching when the junction temperature exceeds the thermal trip threshold. Once the die temperature decreases below 150°C, the device reinitiates the power up sequence by discharging the SS pin to below 65 mV. The thermal shutdown hysteresis is 15°C.

7.3.16 Small Signal Model for Loop Response

Figure 31 shows an equivalent model for the TPS54478 control loop which can be modeled in a circuit simulation program to check frequency response and dynamic load response without slope compensation effect. The error amplifier is a transconductance amplifier with a \( gm = 225 \, \mu\text{A/V} \). The error amplifier can be modeled using an ideal voltage controlled current source. The resistor \( R_0 \) and capacitor \( C_0 \) model the open loop gain and frequency response of the amplifier. The 1-mV AC voltage source between the nodes a and b effectively breaks the control loop for the frequency response measurements. Plotting \( a/c \) shows the small signal response of the frequency compensation. Plotting \( a/b \) shows the small signal response of the overall loop. The dynamic loop response can be checked by replacing the \( R_L \) with a current source with the appropriate load step amplitude and step rate in a time domain analysis.

Figure 31. Small Signal Model for Loop Response Without Slope Comp Effect

7.3.17 Simple Small Signal Model for Peak Current Mode Control

Figure 31 is a simple small signal model that can be used to understand how to design the frequency compensation without slope compensation effect. The TPS54478 power stage can be approximated to a voltage controlled current source (duty cycle modulator) supplying current to the output capacitor and load resistor. The control to output transfer function is shown in Equation 9 and consists of a dc gain, one dominant pole and one ESR zero. The quotient of the change in switch current and the change in COMP pin voltage (node c in Figure 31) is the power stage transconductance. The \( gm \) for the TPS54478 is 14 A/V. The low frequency gain of the power stage frequency response is the product of the transconductance and the load resistance as shown in Equation 10. As the load current increases and decreases, the low frequency gain decreases and increases,
Feature Description (continued)

respectively. This variation with load may seem problematic at first glance, but the dominant pole moves with load current (see Equation 11). The combined effect is highlighted by the dashed line in the right half of Figure 32. As the load current decreases, the gain increases and the pole frequency lowers, keeping the 0-dB crossover frequency the same for the varying load conditions which makes it easier to design the frequency compensation.

\[ \frac{v_o}{v_c} = Adc \times \frac{1 + \frac{s}{2\pi \times f_z}}{1 + \frac{s}{2\pi \times f_p}} \]

\[ Adc = gm_{ps} \times R_L \]

\[ f_p = \frac{1}{C_{OUT} \times R_L \times 2\pi} \]

\[ f_z = \frac{1}{C_{OUT} \times R_{ESR} \times 2\pi} \]

7.3.18 Small Signal Model for Frequency Compensation

The TPS54478 uses a transconductance amplifier for the error amplifier and readily supports two of the commonly used frequency compensation circuits. The compensation circuits are shown in Figure 33. The Type 2 circuits are most likely implemented in high bandwidth power supply designs using low ESR output capacitors. In Type 2A, one additional high frequency pole is added to attenuate high frequency noise.

Figure 32. Simple Small Signal Model and Frequency Response for Peak Current Mode Control without Slope Comp Effect
Feature Description (continued)

The design guidelines for TPS54478 loop compensation are addressed in the Application Information section with more details. The approach is to run the Pspice model first to find the accurate response of the power stage with slope compensation effect. The compensation network is then designed based on the desired crossover frequency. The crossover frequency and phase margin are more closer to the measured results when the slope compensation effect is included.

For type-II compensation, the modulator pole, $f_{p\,\text{mod}}$, and the esr zero, $f_{z\,\text{mod}}$ can be calculated using Equation 13 and Equation 14. Derating the output capacitor ($C_{\text{OUT}}$) is needed if the output voltage is a high percentage of the capacitor rating. Use the capacitor manufacturer information to derate the capacitor value. Use Equation 15 and Equation 16 to estimate a starting point for the crossover frequency, $f_c$. Equation 15 is the geometric mean of the modulator pole and the esr zero and Equation 16 is the mean of modulator pole and the switching frequency. Use the lower value of Equation 15 or Equation 16 as the maximum crossover frequency.

$$f_{p\,\text{mod}} = \frac{I_{\text{out\,max}}}{2\pi \times V_{\text{out}} \times C_{\text{out}}}$$  \hspace{1cm} (13)  

$$f_{z\,\text{mod}} = \frac{1}{2\pi \times \text{Resr} \times C_{\text{out}}}$$  \hspace{1cm} (14)  

$$f_{c} = \sqrt{f_{p\,\text{mod}} \times f_{z\,\text{mod}}}$$  \hspace{1cm} (15)  

$$f_{c} = \sqrt{f_{p\,\text{mod}} \times \frac{f_{\text{sw}}}{2}}$$  \hspace{1cm} (16)  

The type-III compensation is recommended to achieve higher crossover frequency by introducing extra phase lift. By adding a small capacitor $C_3$ in parallel with $R_1$, one-pair of zero and pole is generated as given by Equation 17 and Equation 18. The Application Information section provides step-by-step design guidelines for Type-III compensation with the effect of slope compensation included.
Feature Description (continued)

![Type-III of Frequency Compensation](image)

\[ f_z = \frac{1}{2\pi \times R_1 \times C_3} \]  
\[ (17) \]

\[ f_p = \frac{1}{2\pi \times (R_1 / R_2) \times C_3} \]  
\[ (18) \]

7.4 Device Functional Modes

7.4.1 PWM Operation

TPS54478 is a synchronous buck converter. Normal operation occurs when \( V_{IN} \) is above 2.95 V and the SS/ENA pins is high to enable the device.

7.4.2 Standby Operation

TPS54478 can be placed in standby when the SS/ENA pin is set low, disabling the device.

7.5 Programming

7.5.1 Sequencing

Many of the common power supply sequencing methods can be implemented using the SS/TR, EN, and PWRGD pins. The sequential method can be implemented using an open drain or collector output of a power on reset pin of another device. Figure 23 shows the sequential method. The PWRGD is coupled to the EN pin on the TPS54478 which enables the second power supply once the primary supply reaches regulation.

Ratio-metric start up can be accomplished by connecting the SS/TR pins together. The regulator outputs ramp up and reach regulation at the same time. When calculating the slow start time the pull up current source must be doubled in Equation 4. The ratio metric method is illustrated in Figure 25.
8 Application and Implementation

NOTE
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI’s customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information
TPS54478 is a synchronous buck converter. It can convert an input voltage of 2.95 V to 6 V to a lower voltage. Maximum output current is 4 A.

8.2 Typical Application
The schematic diagram for this design example is shown in Figure 36. The component reference designators of this schematic are used for the equations in Detailed Design Procedure.

8.2.1 Design Requirements
This example details the design of a high frequency switching regulator design using ceramic output capacitors. This design is available as the TPS54478EVM-037 (PWR037) evaluation module (EVM). A few parameters must be known in order to start the design process. These parameters are typically determined on the system level. For this example, start with the following known parameters:

<table>
<thead>
<tr>
<th>DESIGN PARAMETER</th>
<th>EXAMPLE VALUE</th>
</tr>
</thead>
<tbody>
<tr>
<td>Output Voltage</td>
<td>1.8 V</td>
</tr>
<tr>
<td>Transient Response 1 A to 3.0 A load step</td>
<td>ΔVout = 3%</td>
</tr>
<tr>
<td>Maximum Output Current</td>
<td>4 A</td>
</tr>
<tr>
<td>Input Voltage</td>
<td>3 V to 6 V, 5 V nominal</td>
</tr>
<tr>
<td>Output Voltage Ripple</td>
<td>&lt; 30 mV p-p</td>
</tr>
<tr>
<td>Switching Frequency (Fsw)</td>
<td>1000 kHz</td>
</tr>
</tbody>
</table>
8.2.2 Detailed Design Procedure

8.2.2.1 Selecting the Switching Frequency

The first step is to decide on a switching frequency for the regulator. Typically, choose the highest switching frequency possible since this produces the smallest solution size. The high switching frequency allows for lower valued inductors and smaller output capacitors compared to a power supply that switches at a lower frequency. However, the highest switching frequency causes extra switching losses, which hurt the converter’s performance. The converter is capable of running from 300 kHz to 2 MHz. Unless a small solution size is an ultimate goal, a moderate switching frequency of 1 MHz is selected to achieve both a small solution size and a high efficiency operation. Using Equation 7, R4 is calculated to be 35.4 kΩ. A standard 1% 35.7 kΩ value was chosen in the design.

![Figure 36. High Frequency, 1.8 V Output Power Supply Design with Adjusted UVLO](image)

8.2.2.2 Output Inductor Selection

The inductor selected works for the entire TPS54478 input voltage range. To calculate the value of the output inductor, use Equation 19. K_{IND} is a coefficient that represents the amount of inductor ripple current relative to the maximum output current. The inductor ripple current is filtered by the output capacitor. Therefore, choosing high inductor ripple currents impacts the selection of the output capacitor since the output capacitor must have a ripple current rating equal to or greater than the inductor ripple current. In general, the inductor ripple value is at the discretion of the designer; however, K_{IND} is normally from 0.1 to 0.3 for the majority of applications.

For this design example, use K_{IND} = 0.3 and the inductor value is calculated to be 1.05 μH. For this design, a nearest standard value was chosen: 1.2 μH. For the output filter inductor, it is important that the RMS current and saturation current ratings not be exceeded. The RMS and peak inductor current can be found from Equation 21 and Equation 22.

For this design, the RMS inductor current is 4.01 A and the peak inductor current is 4.53 A. The chosen inductor is a Coilcraft XAL5030-122ME. It has a saturation current rating of 11.8 A (20% inductance loss) and a RMS current rating of 8.7 A (20 °C temperature rise). The series resistance is 6.78 mΩ typical.

The current flowing through the inductor is the inductor ripple current plus the output current. During power up, faults or transient load conditions, the inductor current can increase above the calculated peak inductor current level calculated above. In transient conditions, the inductor current can increase up to the switch current limit of the device. For this reason, the most conservative approach is to specify an inductor with a saturation current rating equal to or greater than the switch current limit rather than the peak inductor current.

\[
L_1 = \frac{\text{Vinmax} - \text{Vout}}{\text{Io} \times \text{Kind}} \times \frac{\text{Vout}}{\text{Vinmax} \times f_{sw}}
\]

(19)

\[
I_{ripple} = \frac{\text{Vinmax} - \text{Vout}}{L_1} \times \frac{\text{Vout}}{\text{Vinmax} \times f_{sw}}
\]

(20)
8.2.2.3 Output Capacitor

There are three primary considerations for selecting the value of the output capacitor. The output capacitor determines the modulator pole, the output voltage ripple, and how the regulator responds to a large change in load current. The output capacitance needs to be selected based on the more stringent of these three criteria.

The desired response to a large change in the load current is the first criteria. The output capacitor needs to supply the load with current when the regulator can not. This situation would occur if there are desired hold-up times for the regulator where the output capacitor must hold the output voltage above a certain level for a specified amount of time after the input power is removed. The regulator is temporarily not able to supply sufficient output current if there is a large, fast increase in the current needs of the load such as transitioning from no load to a full load. The regulator usually needs two or more clock cycles for the control loop to see the change in load current and output voltage and adjust the duty cycle to react to the change. The output capacitor must be sized to supply the extra current to the load until the control loop responds to the load change. The output capacitance must be large enough to supply the difference in current for 2 clock cycles while only allowing a tolerable amount of droop in the output voltage. Equation 23 shows the minimum output capacitance necessary to accomplish this.

For this example, the transient load response is specified as a 3% change in Vout for a load step from 1 A (25% load) to 3 A (75% load). For this example, \( \Delta I_{\text{out}} = 3 - 1 = 2.0 \) A and \( \Delta V_{\text{out}} = 0.03 \times 1.8 = 0.054 \) V. Using these numbers gives a minimum capacitance of 74.1 \( \mu \)F. This value does not take the ESR of the output capacitor into account in the output voltage change. For ceramic capacitors, the ESR is usually small enough to ignore in this calculation.

Equation 24 calculates the minimum output capacitance needed to meet the output voltage ripple specification. Where \( f_{\text{sw}} \) is the switching frequency, \( V_{\text{ripple}} \) is the maximum allowable output voltage ripple, and \( I_{\text{ripple}} \) is the inductor ripple current. In this case, the maximum output voltage ripple is 30 mV. Under this requirement, Equation 24 yields 4.4 \( \mu \)F.

\[
\begin{align*}
\text{Equation 23:} & \quad C_{\text{o}} > \frac{2 \times \Delta I_{\text{out}}}{f_{\text{sw}} \times \Delta V_{\text{out}}} \\
\text{where} & \quad \Delta I_{\text{out}} \text{ is the change in output current, } f_{\text{sw}} \text{ is the regulator's switching frequency and } \Delta V_{\text{out}} \text{ is the allowable change in the output voltage.} \\
\text{Equation 24:} & \quad C_{\text{o}} > \frac{1}{8 \times f_{\text{sw}}} \times \frac{1}{V_{\text{ripple}}} \times \frac{1}{I_{\text{ripple}}} \\
\end{align*}
\]

Equation 25 calculates the maximum ESR an output capacitor can have to meet the output voltage ripple specification. Equation 25 indicates the ESR should be less than 28.6 m\( \Omega \). In this case, the ESR of the ceramic capacitor is much less than 28.6 m\( \Omega \).

Additional capacitance de-ratings for aging, temperature and DC bias should be factored in which increases this minimum value. For this example, two 47 \( \mu \)F 10 V X5R ceramic capacitors with 3 m\( \Omega \) of ESR are used. The estimated capacitance after derating is \( 2 \times 45 \mu F = 90 \mu F \).
Capacitors generally have limits to the amount of ripple current they can handle without failing or producing excess heat. An output capacitor that can support the inductor ripple current must be specified. Some capacitor data sheets specify the RMS (Root Mean Square) value of the maximum ripple current. Equation 26 can be used to calculate the RMS ripple current the output capacitor needs to support. For this application, Equation 26 yields 303 mA.

\[
\text{Resr} < \frac{V_{\text{ripple}}}{I_{\text{ripple}}} \tag{25}
\]

\[
I_{\text{cirms}} = \frac{V_{\text{out}} \times (V_{\text{inmax}} - V_{\text{out}})}{\sqrt{12} \times V_{\text{inmax}} \times L1 \times f_{\text{sw}}} \tag{26}
\]

### 8.2.2.4 Input Capacitor

The TPS54478 requires a high quality ceramic, type X5R or X7R, input decoupling capacitor of at least 10 μF of effective capacitance and in some applications a bulk capacitance. The effective capacitance includes any DC bias effects. The voltage rating of the input capacitor must be greater than the maximum input voltage. The capacitor must also have a ripple current rating greater than the maximum input current ripple of the TPS54478. The input ripple current can be calculated using Equation 27.

The value of a ceramic capacitor varies significantly over temperature and the amount of DC bias applied to the capacitor. The capacitance variations due to temperature can be minimized by selecting a dielectric material that is stable over temperature. X5R and X7R ceramic dielectrics are usually selected for power regulator capacitors because they have a high capacitance to volume ratio and are fairly stable over temperature. The output capacitor must also be selected with the DC bias taken into account. The capacitance value of a capacitor decreases as the DC bias across a capacitor increases.

For this example design, a ceramic capacitor with at least a 10 V voltage rating is required to support the maximum input voltage. For this example, one 10 μF and one 0.1 μF 10 V capacitors in parallel have been selected.

\[
\Delta V_{\text{in}} = \frac{l_{\text{out max}} \times 0.25}{C_{\text{in}} \times f_{\text{sw}}} \tag{28}
\]

### 8.2.2.5 Slow Start Capacitor

The slow start capacitor determines the minimum amount of time it takes for the output voltage to reach its nominal programmed value during power up. This is useful if a load requires a controlled voltage slew rate. This is also used if the output capacitance is very large and would require large amounts of current to quickly charge the capacitor to the output voltage level. The large currents necessary to charge the capacitor may make the TPS54478 reach the current limit or excessive current draw from the input power supply may cause the input voltage rail to sag. Limiting the output voltage slew rate solves both of these problems.

The slow start capacitor value can be calculated using Equation 29. For the example circuit, the slow start time is not too critical since the output capacitor value is 2 x 47 μF which does not require much current to charge to 1.8 V. The example circuit has the slow start time set to an arbitrary value of 3.33 ms which requires a 10 nF capacitor.

\[
C6(\text{nF}) = 3 \cdot \text{Tss(mS)} \tag{29}
\]

### 8.2.2.6 Bootstrap Capacitor Selection

A 0.1-μF ceramic capacitor must be connected between the BOOT to PH pin for proper operation. It is recommended to use a ceramic capacitor with X5R or better grade dielectric. The capacitor should have 10 V or higher voltage rating.
8.2.2.7 Output Voltage and Feedback Resistors Selection

For the example design, 10.0 kΩ was selected for R7. Using Equation 30, R6 is calculated as 20.0 kΩ. The nearest standard 1% resistor is 20.0 kΩ.

\[
R6 = R7 \cdot \left( \frac{V_{OUT}}{V_{REF}} - 1 \right)
\]  

(30)

Due to the internal design of the TPS54478, there is a minimum output voltage limit for any given input voltage. The output voltage can never be lower than the internal voltage reference of 0.6 V. Above 0.6 V, the output voltage may be limited by the minimum controllable on time. The minimum output voltage in this case is given by Equation 31:

\[
V_{outmin} = Ontimemin \times F_{max} \times (Vinmax - I_{outmin} \times R_{DSmin}) - I_{outmin} \times (R_L + R_{DSmin})
\]

where
- \( V_{outmin} \) = minimum achievable output voltage
- \( Ontimemin \) = minimum controllable on-time (100 ns typical, 120 ns no load)
- \( F_{max} \) = maximum switching frequency including tolerance
- \( Vinmax \) = maximum input voltage
- \( I_{outmin} \) = minimum load current
- \( R_{DSmin} \) = minimum high-side MOSFET on resistance (see Electrical Characteristics)
- \( R_L \) = series resistance of output inductor

There is also a maximum achievable output voltage which is limited by the minimum off time. The maximum output voltage is given by Equation 32:

\[
V_{outmax} = Vin \times \left( 1 - \frac{Offtimemax}{ts} \right) - I_{outmax} \times (R_{DSmax} + RI) - (0.7 - I_{outmax} \times R_{DSmax}) \times \left( \frac{t_{dead}}{ts} \right)
\]

where
- \( V_{outmax} \) = maximum achievable output voltage
- \( Vin \) = minimum input voltage
- \( Offtimemax \) = maximum off time (180 ns typical for adequate margin)
- \( ts = 1/F_s \)
- \( I_{outmax} \) = maximum current
- \( R_{DSmax} \) = maximum high-side MOSFET on resistance (see Electrical Characteristics)
- \( RI = DCR \) of the inductor
- \( t_{dead} \) = dead time (40 ns)

(32)

8.2.2.8 Compensation

There are several possible methods to design closed loop compensation for dc/dc converters. For the ideal current mode control, the design equations can be easily simplified. The power stage gain is constant at low frequencies, and rolls off at -20 dB/decade above the modulator pole frequency. The power stage phase is 0 degrees at low frequencies and starts to fall one decade above the modulator pole frequency reaching a minimum of -90 degrees one decade above the modulator pole frequency. The modulator pole is a simple pole shown in Equation 33.

\[
F_{PMOD} = \frac{1}{2 \cdot \pi \cdot C_{OUT} \cdot R_{OUT}}
\]

(33)

For the TPS54478 most circuits will have relatively high amounts of slope compensation. As more slope compensation is applied, the power stage characteristics will deviate from the ideal approximations. The phase loss of the power stage will now approach -180 degrees, making compensation more difficult. The power stage transfer function can be solved but it is a tedious hand calculation that does not lend itself to simple approximations. It is best to use Pspice or TINA-TI to accurately model the power stage gain and phase so that a
A reliable compensation circuit can be designed. That is the technique used in this design procedure. Using the Pspice model of SLVM279 apply the values calculated previously to the output filter components of L1, C9, and C10. Set Rload to the appropriate value. For this design, L1 = 1.2 µH. C8 and C9 use the derated capacitance value of 45 µF, and the ESR is set to 3 mΩ. The Rload resistor is 1.8 / 4 = 450 mΩ. Now the power stage characteristic can be plotted as shown in Figure 37.

**Figure 37. Power Stage Gain and Phase Characteristics**

For this design, the intended crossover frequency is 70 kHz. From the power stage gain and phase plots, the gain at 70 kHz is -12.03 dB and the phase is -131.86 degrees. For 60 degrees of phase margin, additional phase boost from a feed forward capacitor in parallel with the upper resistor of the voltage set point divider will be required. R3 sets the gain of the compensated error amplifier to be equal and opposite the power stage gain at crossover. The required value of R3 can be calculated from Equation 34.

\[
R3 = \frac{-G_{PWRSTG}}{\text{gm}_{EA}} \cdot \frac{\text{V}_{out}}{\text{V}_{REF}}
\]

(34)

To maximize phase gain, the compensator zero is placed one decade below the crossover frequency of 70 kHz. The required value for C5 is given by Equation 35.

\[
C5 = \frac{1}{2 \cdot \pi \cdot R3 \cdot \frac{F_{CO}}{10}}
\]

(35)

To maximize phase gain the high frequency pole is not implemented and C4 is not populated. The pole can be useful to offset the ESR of aluminum electrolytic output capacitors. If desired the value for C4 can be calculated from Equation 36.

\[
C4 = \frac{1}{2 \cdot \pi \cdot R3 \cdot F_{P}}
\]

(36)

For maximum phase boost, the pole frequency \(F_{P}\) will typically be one decade above the intended crossover frequency \(F_{CO}\). The feed forward capacitor C10, is used to increase the phase boost at crossover above what is normally available from Type II compensation. It places an additional zero/pole pair located at Equation 37 and Equation 38.

\[
F_{Z} = \frac{1}{2 \cdot \pi \cdot C10 \cdot R6}
\]

(37)

\[
F_{P} = \frac{1}{2 \cdot \pi \cdot C10 \cdot R6 \parallel R7}
\]

(38)
This zero and pole pair is not independent. Once the zero location is chosen, the pole is fixed as well. For optimum performance, the zero and pole should be located symmetrically about the intended crossover frequency. The required value for C10 can be calculated from Equation 39.

\[
C10 = \frac{1}{2 \cdot \pi \cdot R6 \cdot FCO \cdot \sqrt{\frac{V_{REF}}{V_{OUT}}}}
\]

(39)

For this design the calculated values for the compensation components are \( R3 = 30.6 \, \text{k}\Omega, C5 = 736 \, \text{pF} \) and \( C10 = 197 \, \text{pF} \). Using standard values, the compensation components are \( R3 = 30.9 \, \text{k}\Omega, C5 = 820 \, \text{pF} \) and \( C10 = 220 \, \text{pF} \).

8.2.3 Application Curves

![Figure 38. Efficiency vs Load Current](image1)

![Figure 39. Efficiency vs Load Current](image2)

![Figure 40. Transient Response, 2 A Step](image3)

![Figure 41. Power Up VOUT, VIN](image4)
9 Power Supply Recommendations

The device is designed to operate from an input-voltage supply range between 2.95 V and 6 V. This input supply should be well regulated. If the input supply is located more than a few inches from the converter, additional bulk capacitance may be required in addition to the ceramic bypass capacitors. An electrolytic capacitor with a value of 100 μF is a typical choice.
10 Layout

10.1 Layout Guidelines

Layout is a critical portion of good power supply design. There are several signal paths that conduct fast changing currents or voltages that can interact with stray inductance or parasitic capacitance to generate noise or degrade the power supplies performance. Care should be taken to minimize the loop area formed by the bypass capacitor connections and the VIN pins. See Figure 54 for a PCB layout example. The GND pins and AGND pin should be tied directly to the power pad under the IC. The power pad should be connected to any internal PCB ground planes using multiple vias directly under the IC. Additional vias can be used to connect the top side ground area to the internal planes near the input and output capacitors. For operation at full rated load, the top side ground area along with any additional internal ground planes must provide adequate heat dissipating area.

Locate the input bypass capacitor as close to the IC as possible. The PH pin should be routed to the output inductor. Since the PH connection is the switching node, the output inductor should be located very close to the PH pins, and the area of the PCB conductor minimized to prevent excessive capacitive coupling. The boot capacitor must also be located close to the device. The sensitive analog ground connections for the feedback voltage divider, compensation components, slow start capacitor and frequency set resistor should be connected to a separate analog ground trace as shown. The RT/CLK pin is particularly sensitive to noise so the RT resistor should be located as close as possible to the IC and routed with minimal lengths of trace. The additional external components can be placed approximately as shown. It may be possible to obtain acceptable performance with alternate PCB layouts, however this layout has been shown to produce good results and is meant as a guideline.

10.2 Layout Example
10.3 Power Dissipation Estimate

The following formulas show how to estimate the IC power dissipation under continuous conduction mode (CCM) operation. The power dissipation of the IC (Ptot) includes conduction loss (Pcon), dead time loss (Pd), switching loss (Psw), gate drive loss (Pgd) and supply current loss (Pq).

\[
\begin{align*}
P_{\text{con}} &= I_o^2 \times R_{\text{DS(on Temp)}} \\
P_{\text{d}} &= f_{\text{sw}} \times I_o \times 0.7 \times 40 \times 10^{-9} \\
P_{\text{sw}} &= 1/2 \times V_{\text{in}} \times I_o \times f_{\text{sw}} \times 7 \times 10^{-9} \\
P_{\text{gd}} &= 2 \times V_{\text{in}} \times f_{\text{sw}} \times 6 \times 10^{-9} \\
P_{\text{q}} &= V_{\text{in}} \times 525 \times 10^{-6}
\end{align*}
\]

Where:
- \(I_o\) is the output current (A).
- \(R_{\text{DS(on Temp)}}\) is the on-resistance of the high-side MOSFET with given temperature (Ω).
- \(V_{\text{in}}\) is the input voltage (V).
- \(f_{\text{sw}}\) is the switching frequency (Hz).

So
\[
P_{\text{tot}} = P_{\text{con}} + P_{\text{d}} + P_{\text{sw}} + P_{\text{gd}} + P_{\text{q}}
\]

For given \(T_A\),
\[
T_J = T_A + R_{\text{th}} \times P_{\text{tot}}
\]

For given \(T_{J\text{MAX}} = 150^\circ\text{C}\)
\[
T_{A\text{MAX}} = T_{J\text{MAX}} - R_{\text{th}} \times P_{\text{tot}}
\]

Where:
- \(P_{\text{tot}}\) is the total device power dissipation (W).
- \(T_A\) is the ambient temperature (°C).
- \(T_J\) is the junction temperature (°C).
- \(R_{\text{th}}\) is the thermal resistance of the package (°C/W).
- \(T_{J\text{MAX}}\) is maximum junction temperature (°C).
- \(T_{A\text{MAX}}\) is maximum ambient temperature (°C).

There are additional power losses in the regulator circuit due to the inductor AC and DC losses and trace resistance that impact the overall efficiency of the regulator.
11 Device and Documentation Support

11.1 Device Support

11.1.1 Third-Party Products Disclaimer
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11.1.2 Custom Design With WEBENCH® Tools
Click here to create a custom design using the TPS54478 device with the WEBENCH® Power Designer.

1. Start by entering the input voltage \( V_{\text{IN}} \), output voltage \( V_{\text{OUT}} \), and output current \( I_{\text{OUT}} \) requirements.
2. Optimize the design for key parameters such as efficiency, footprint, and cost using the optimizer dial.
3. Compare the generated design with other possible solutions from Texas Instruments.

The WEBENCH Power Designer provides a customized schematic along with a list of materials with real-time pricing and component availability.

In most cases, these actions are available:
• Run electrical simulations to see important waveforms and circuit performance
• Run thermal simulations to understand board thermal performance
• Export customized schematic and layout into popular CAD formats
• Print PDF reports for the design, and share the design with colleagues

Get more information about WEBENCH tools at www.ti.com/WEBENCH.

11.2 Documentation Support

11.2.1 Related Documentation
For related documentation see the following:
• For SWIFT™ documentation, see the TI website at www.ti.com/swift
• TPS54478EVM-037 4-A, SWIFT™ Regulator Evaluation Module User's Guide (SLVU470)

11.3 Receiving Notification of Documentation Updates
To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on Alert me to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.4 Community Resources
The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community  TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support  TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.5 Trademarks
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WEBENCH is a registered trademark of Texas Instruments.
All other trademarks are the property of their respective owners.
11.6 Electrostatic Discharge Caution

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.
## PACKAGING INFORMATION

<table>
<thead>
<tr>
<th>Orderable Device</th>
<th>Status (1)</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>Package Qty</th>
<th>Eco Plan (2)</th>
<th>Lead/Ball Finish (6)</th>
<th>MSL Peak Temp (3)</th>
<th>Op Temp (°C)</th>
<th>Device Marking (4/5)</th>
<th>Samples</th>
</tr>
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<tbody>
<tr>
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<td>RTE</td>
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<td>Level-2-260C-1 YEAR</td>
<td>-40 to 150</td>
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<td>54478</td>
<td>Samples</td>
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</tbody>
</table>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBsolete:** TI has discontinued the production of the device.

(2) RoHS: TI defines “RoHS” to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines “RoHS Exempt” to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines “Green” to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION

**TAPE DIMENSIONS**

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<th>A0</th>
<th>Dimension designed to accommodate the component width</th>
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<tbody>
<tr>
<td>B0</td>
<td>Dimension designed to accommodate the component length</td>
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<tr>
<td>K0</td>
<td>Dimension designed to accommodate the component thickness</td>
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<td>W</td>
<td>Overall width of the carrier tape</td>
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<tr>
<td>P1</td>
<td>Pitch between successive cavity centers</td>
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**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**

*All dimensions are nominal*

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<th>B0 (mm)</th>
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TAPE AND REEL BOX DIMENSIONS

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</tr>
<tr>
<td>TPS54478RTET</td>
<td>WQFN</td>
<td>RTE</td>
<td>16</td>
<td>250</td>
<td>210.0</td>
<td>185.0</td>
<td>35.0</td>
</tr>
</tbody>
</table>

*All dimensions are nominal*
NOTES:
A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
B. This drawing is subject to change without notice.
C. Quad Flatpack, No-Leads (QFN) package configuration.
   The package thermal pad must be soldered to the board for thermal and mechanical performance.
   See the Product Data Sheet for details regarding the exposed thermal pad dimensions.
D. Falls within JEDEC MO-220.

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THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.

NOTE: A. All linear dimensions are in millimeters.
NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Publication IPC-7351 is recommended for alternate designs.
D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <http://www.ti.com>.
E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.
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